Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination
10/824,871	CHANG ET AL.
Examiner	Art Unit
Joseph Nguyen	2815

SEARCHED				
Class	Subclass	Date	Examiner	
257	79	4/21/2005	JN	
257	e33.026	4/21/2005	JN	
257	e33.031	4/21/2005	JN	
438	455,47	4/21/2005	JN	
257	94	4/25/2005	JN	

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
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SEARCH I (INCLUDING SEAR	CH STRATEG	Y)
	DATE	EXMR
See copy of search history	4/25/2005	ИС